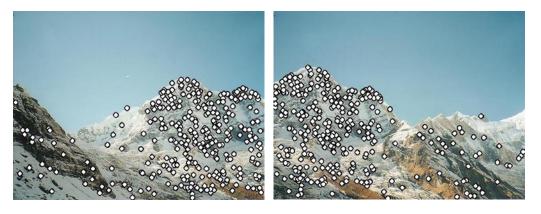
Correspondence: Feature detection

A general pipeline for correspondence

- 1. If sparse correspondences are enough, choose points for which we will search for correspondences (feature points)
- 2. For each point (or every pixel if dense correspondence), describe point using a *feature descriptor*
- 3. Find best matching descriptors across two images (*feature matching*)
- 4. Use feature matches to perform downstream task, e.g., pose estimation

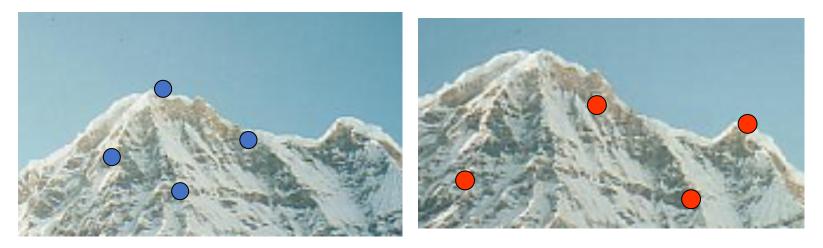
Characteristics of good feature points



- Repeatability / invariance
 - The same feature point can be found in several images despite geometric and photometric transformations
- Saliency / distinctiveness
 - Each feature point is distinctive
 - Fewer "false" matches

Goal: repeatability

• We want to detect (at least some of) the same points in both images.



No chance to find true matches!

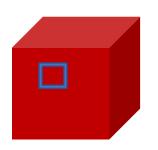
• Yet we have to be able to run the detection procedure *independently* per image.

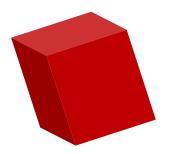
Goal: distinctiveness

- The feature point should be distinctive enough that it is easy to match
 - Should *at least* be distinctive from other patches nearby

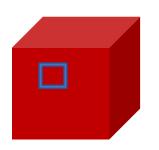


- Individual pixels are ambiguous
- Idea: Look at whole patches!



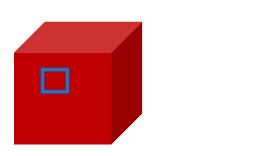


- Individual pixels are ambiguous
- Idea: Look at whole patches!

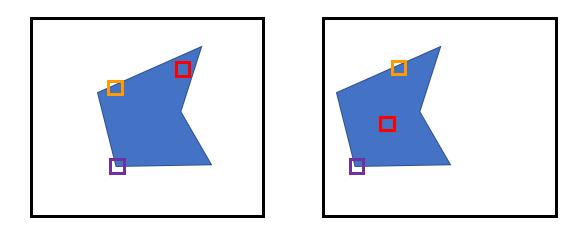




• Some local neighborhoods are ambiguous

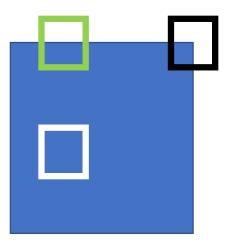






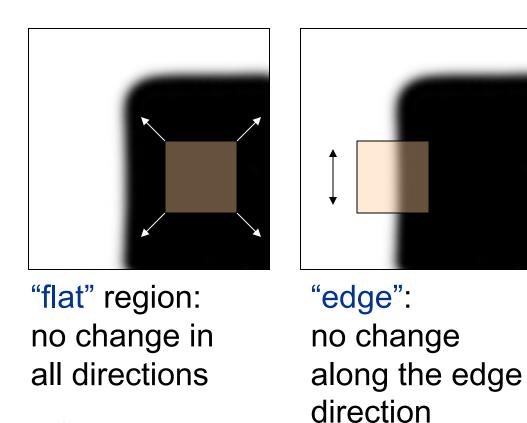
Corner detection

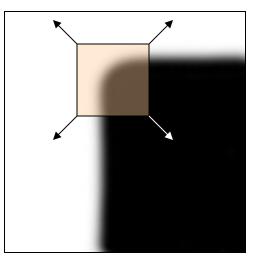
• Main idea: Translating window should cause large differences in patch appearance



Corner Detection: Basic Idea

- We should easily recognize the point by looking through a small window
- Shifting a window in *any direction* should give *a large change* in intensity



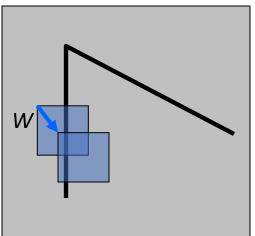


"corner": significant change in all directions

Source: A. Efros

Corner detection the math

- Consider shifting the window W by (u,v)
 - how do the pixels in W change?
- Write pixels in window as a vector:



$$\phi_0 = [I(0,0), I(0,1), \dots, I(n,n)]$$

$$\phi_1 = [I(0+u, 0+v), I(0+u, 1+v), \dots, I(n+u, n+v)]$$

$$E(u,v) = \|\phi_0 - \phi_1\|_2^2$$

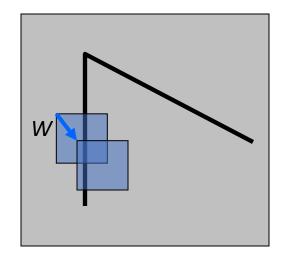
Corner detection: the math

Consider shifting the window W by (u,v)

- how do the pixels in W change?
- compare each pixel before and after by summing up the squared differences (SSD)
- this defines an SSD "error" E(u,v):
 E(u,v)

$$= \sum_{(x,y)\in W} [I(x+u,y+v) - I(x,y)]^2$$

• We want E(u,v) to be as high as possible for all u, v!



Small motion assumption

Taylor Series expansion of *I*:

$$I(x+u, y+v) = I(x, y) + \frac{\partial I}{\partial x}u + \frac{\partial I}{\partial y}v + higher order terms$$

If the motion (u,v) is small, then first order approximation is good

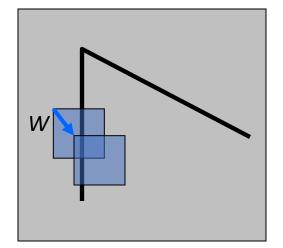
$$I(x + u, y + v) \approx I(x, y) + \frac{\partial I}{\partial x}u + \frac{\partial I}{\partial y}v$$
$$\approx I(x, y) + [I_x \ I_y] \begin{bmatrix} u \\ v \end{bmatrix}$$
shorthand: $I_x = \frac{\partial I}{\partial x}$

Plugging this into the formula on the previous slide...

Corner detection: the math

Consider shifting the window W by (u,v)

• define an SSD "error" *E(u,v)*:



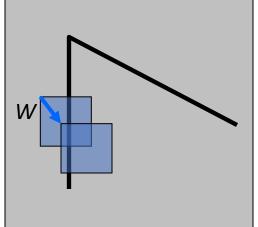
$$E(u, v) = \sum_{\substack{(x,y) \in W \\ (x,y) \in W}} [I(x+u, y+v) - I(x,y)]^2$$

$$\approx \sum_{\substack{(x,y) \in W \\ (x,y) \in W}} [I(x,y) + I_x u + I_y v - I(x,y)]^2$$

Corner detection: the math

Consider shifting the window W by (u, v)

• define an "error" *E(u,v)*:



$$E(u,v) \approx \sum_{\substack{(x,y) \in W}} [I_x u + I_y v]^2$$
$$\approx Au^2 + 2Buv + Cv^2$$
$$A = \sum_{\substack{(x,y) \in W}} I_x^2 \quad B = \sum_{\substack{(x,y) \in W}} I_x I_y \quad C = \sum_{\substack{(x,y) \in W}} I_y^2$$

• Thus, E(u,v) is locally approximated as a quadratic error function

A more general formulation

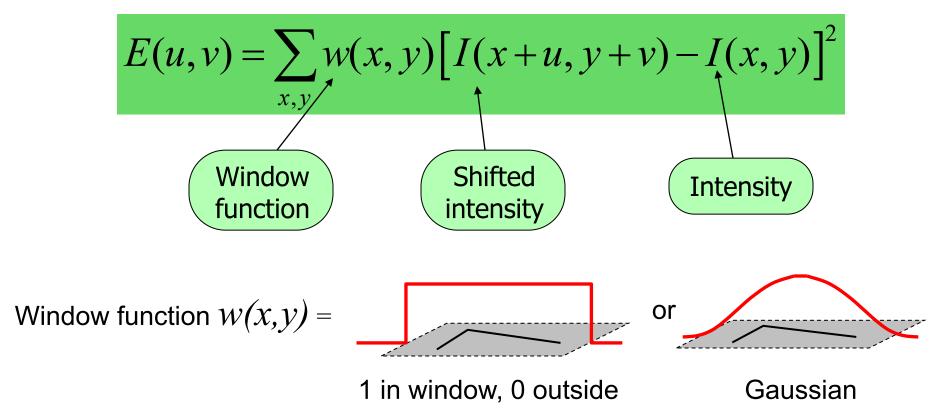
- Maybe all pixels in the patch are not equally important
- Consider a "window function" w(x, y) that acts as weights

•
$$E(u, v) = \sum_{(x,y) \in W} w(x, y) [I(x + u, y + v) - I(x, y)]^2$$

- Case till now:
 - w(x,y) = 1 inside the window, 0 otherwise

Using a window function

• Change in appearance of window w(x,y) for the shift [u,v]:



Redoing the derivation using a window function

$$E(u,v) = \sum_{x,y\in W} w(x,y) [I(x+u,y+v) - I(x,y)]^{2}$$

$$\approx \sum_{x,y\in W} w(x,y) [I(x,y) + uI_{x}(x,y) + vI_{y}(x,y) - I(x,y)]^{2}$$

$$= \sum_{x,y\in W} w(x,y) [uI_{x}(x,y) + vI_{y}(x,y)]^{2}$$

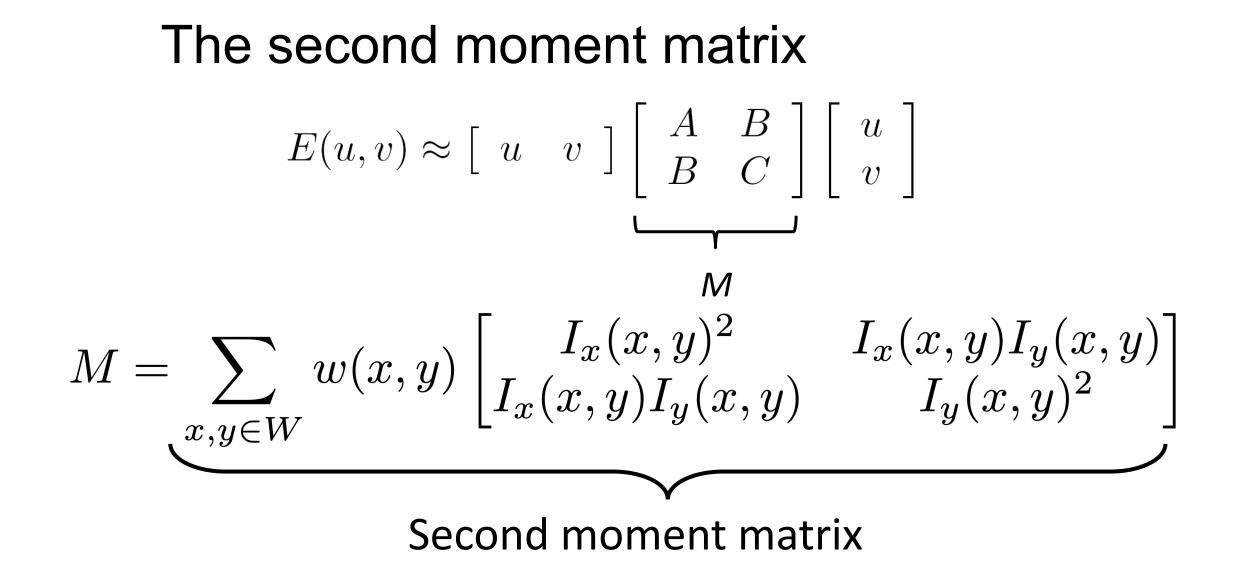
$$= \sum_{x,y\in W} w(x,y) [u^{2}I_{x}(x,y)^{2} + v^{2}I_{y}(x,y)^{2} + 2uvI_{x}(x,y)I_{y}(x,y)]$$

Redoing the derivation using a window function

•

$$E(u, v) \approx \sum_{\substack{x,y \in W \\ x,y \in W}} w(x,y) [u^2 I_x(x,y)^2 + v^2 I_y(x,y)^2 + 2uv I_x(x,y) I_y(x,y)]$$

= $Au^2 + 2Buv + Cv^2$
 $A = \sum_{\substack{x,y \in W \\ x,y \in W}} w(x,y) I_x(x,y)^2$
 $B = \sum_{\substack{x,y \in W \\ x,y \in W}} w(x,y) I_x(x,y) I_y(x,y)$
 $C = \sum_{\substack{x,y \in W \\ x,y \in W}} w(x,y) I_y(x,y)^2$



The second moment matrix $E(u,v) \approx \begin{bmatrix} u & v \end{bmatrix} \begin{bmatrix} A & B \\ B & C \end{bmatrix} \begin{bmatrix} u \\ v \end{bmatrix}$ M $M = \sum_{x,y \in W} w(x,y) \begin{bmatrix} I_x(x,y)^2 & I_x(x,y)I_y(x,y) \\ I_x(x,y)I_y(x,y) & I_y(x,y)^2 \end{bmatrix}$ Second moment matrix Recall that we want E(u,v) to be as large as possible for all u,v What does this mean in terms of M?

$$E(u, v) \approx \begin{bmatrix} u & v \end{bmatrix} \begin{bmatrix} A & B \\ B & C \end{bmatrix} \begin{bmatrix} u \\ v \end{bmatrix}$$

$$A = \sum_{(x,y)\in W} I_x^2$$

$$B = \sum_{(x,y)\in W} I_x I_y$$

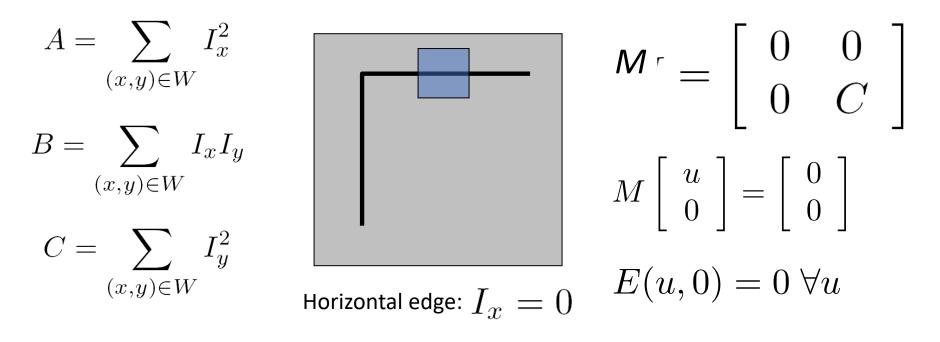
$$C = \sum_{(x,y)\in W} I_y^2$$
Flat patch: $I_x = 0$

$$I_y = 0$$

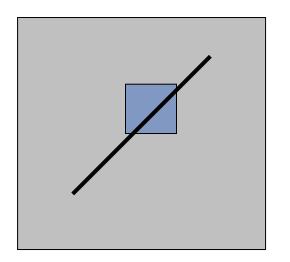
B

$$\begin{split} E(u,v) &\approx \begin{bmatrix} u & v \end{bmatrix} \begin{bmatrix} A & B \\ B & C \end{bmatrix} \begin{bmatrix} u \\ v \end{bmatrix} \\ A &= \sum_{(x,y) \in W} I_x^2 & \mathbf{M} \\ B &= \sum_{(x,y) \in W} I_x I_y \\ C &= \sum_{(x,y) \in W} I_y^2 & \mathbf{V} \\ Vertical edge: I_y &= 0 \\ E(0,v) &= 0 \quad \forall v \end{split}$$

$$E(u,v) \approx \begin{bmatrix} u & v \end{bmatrix} \begin{bmatrix} A & B \\ B & C \end{bmatrix} \begin{bmatrix} u \\ v \end{bmatrix}$$



What about edges in arbitrary orientation?



$$E(u,v) \approx \begin{bmatrix} u & v \end{bmatrix} M \begin{bmatrix} u \\ v \end{bmatrix}$$

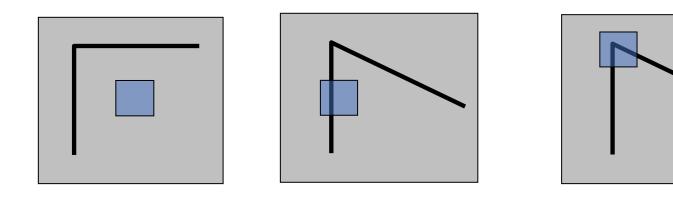
$$M\left[\begin{array}{c} u\\ v\end{array}\right] = \left[\begin{array}{c} 0\\ 0\end{array}\right] \Leftrightarrow E(u,v) = 0$$

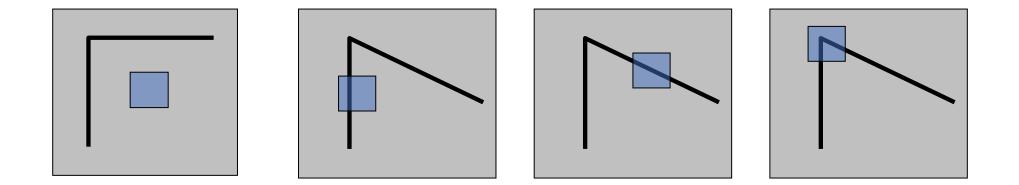
Solutions to Mx = 0 are directions for which E is 0: window can slide in this direction without changing appearance

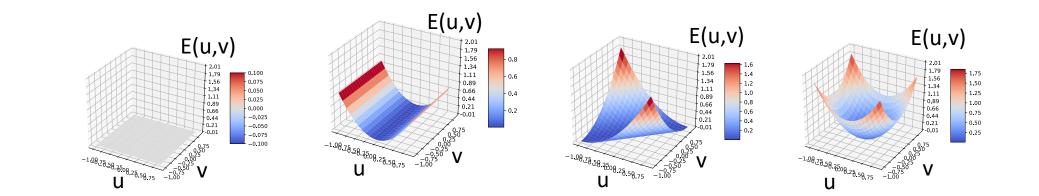
$$E(u,v) \approx \begin{bmatrix} u & v \end{bmatrix} M \begin{bmatrix} u \\ v \end{bmatrix}$$

Solutions to Mx = 0 are directions for which E is 0: window can slide in this direction without changing appearance

For corners, we want no such directions to exist







Eigenvalues and eigenvectors of M

- $Mx = 0 \Rightarrow Mx = \lambda x$: x is an eigenvector of M with eigenvalue 0
- M is 2 x 2, so it has 2 eigenvalues $(\lambda_{max}, \lambda_{min})$ with eigenvectors (x_{max}, x_{min})
- $E(x_{max}) = x_{max}^T M x_{max} = \lambda_{max} ||x_{max}||^2 = \lambda_{max}$ (eigenvectors have unit norm)
- $E(x_{min}) = x_{min}^T M x_{min} = \lambda_{min} ||x_{min}||^2 = \lambda_{min}$

Eigenvalues and eigenvectors of M

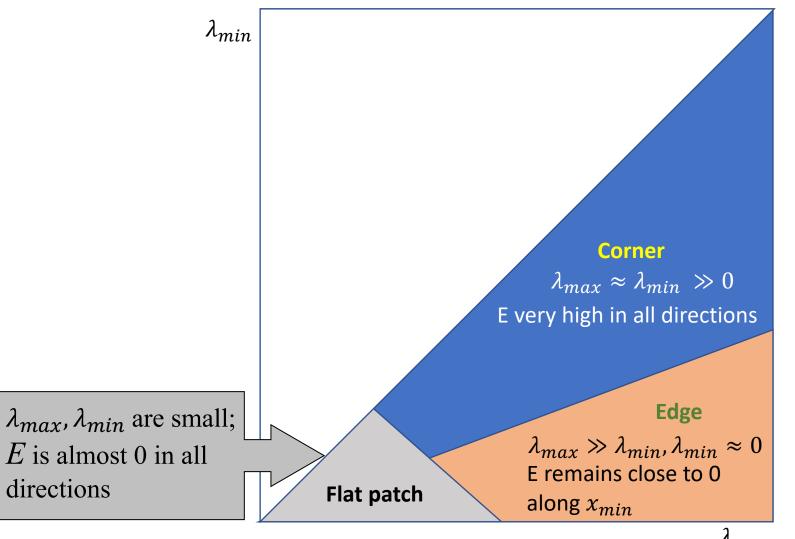
$$E(u, v) \approx \begin{bmatrix} u & v \end{bmatrix} M \begin{bmatrix} u \\ v \end{bmatrix}$$

$$\underset{\mathsf{X}_{\max}}{\overset{\mathsf{X}_{\max}}{\overset{\mathsf{M}}}} \overset{\mathsf{M}}{\underset{\mathsf{M}}{\overset{\mathsf{M}}}} x_{\max} = \lambda_{\max} x_{\max}$$

Eigenvalues and eigenvectors of M

- Define shift directions with the smallest and largest change in error
- x_{max} = direction of largest increase in *E*
- λ_{max} = amount of increase in direction x_{max}
- x_{min} = direction of smallest increase in *E*
- λ_{min} = amount of increase in direction x_{min}

Interpreting the eigenvalues

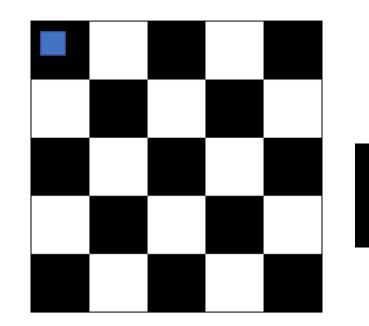


 λ_{max}

Computing the second moment matrix efficiently

$$M = \sum_{x,y \in W} w(x,y) \begin{bmatrix} I_x(x,y)^2 & I_x(x,y)I_y(x,y) \\ I_x(x,y)I_y(x,y) & I_y(x,y)^2 \end{bmatrix}$$

- Window function w(x,y) typically a Gaussian centered on the window
 w(x,y) = e^{-(x-x_0)^2}/(\sigma^2) (y-y_0)^2</sup>/(\sigma^2)
- Need to compute this matrix efficiently for *every* window location



 $w_{x,y}$

Computing the second moment matrix efficiently

$$M = \sum_{x,y \in W} w(x,y) \begin{bmatrix} I_x(x,y)^2 & I_x(x,y)I_y(x,y) \\ I_x(x,y)I_y(x,y) & I_y(x,y)^2 \end{bmatrix}$$

- Step 1: Place k x k window
- Step 2: Compute $\sum_{x,y \in W} w(x,y)I_x(x,y)^2 =$ $\sum_{x,y} e^{-\frac{(x-x_0)^2}{\sigma^2} - \frac{(y-y_0)^2}{\sigma^2}} I_x(x,y)^2$ (similarly other terms)
- This can be expressed as a convolution!

Computing the second moment matrix

- Compute image gradients I_x , I_y (both of these are images)
 - Might want to blur with a Gaussian before doing this. Why?
- Compute I_x^2 , I_y^2 , $I_x I_y$ (these are images too)
- Convolve with windowing function (typically Gaussian)
- Assemble second moment matrix at every pixel

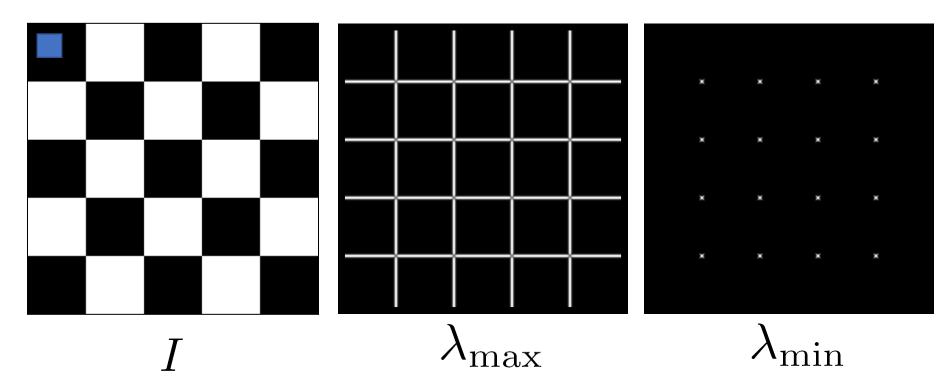
Corner detection: the math

How are λ_{max} , x_{max} , λ_{min} , and x_{min} relevant for feature detection?

• Need a feature scoring function

Want E(u,v) to be large for small shifts in all directions

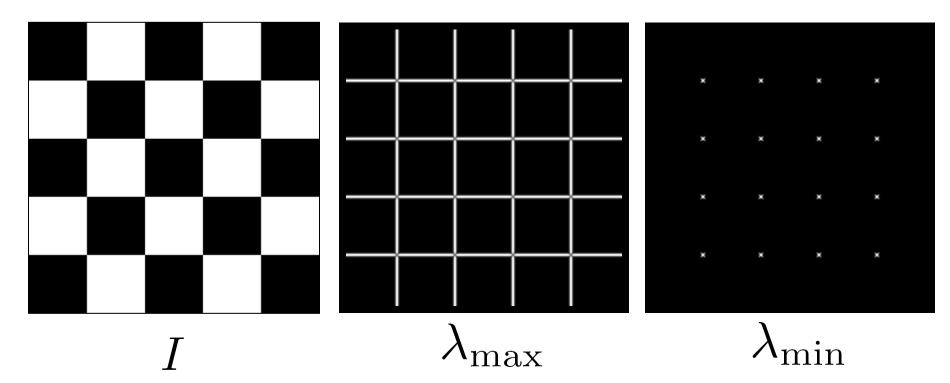
- the minimum of E(u,v) should be large, over all unit vectors [u v]
- this minimum is given by the smaller eigenvalue (λ_{min}) of M



Corner detection summary

Here's what you do

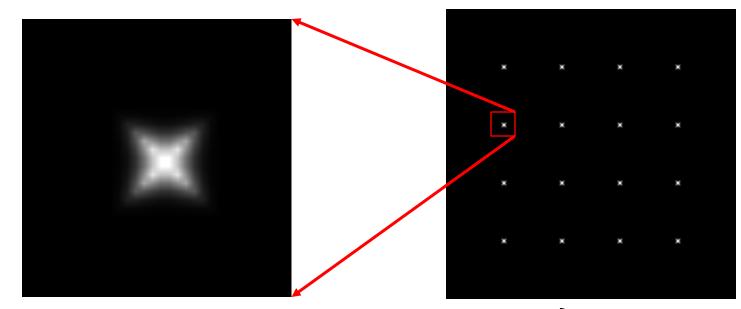
- Compute the gradient at each point in the image
- Create the *M* matrix from the entries in the gradient
- Compute the eigenvalues
- Find points with large response (λ_{min} > threshold)
- Choose those points where λ_{min} is a local maximum as features



Corner detection summary

Here's what you do

- Compute the gradient at each point in the image
- Create the *H* matrix from the entries in the gradient
- Compute the eigenvalues.
- Find points with large response (λ_{min} > threshold)
- Choose those points where λ_{min} is a local maximum as features



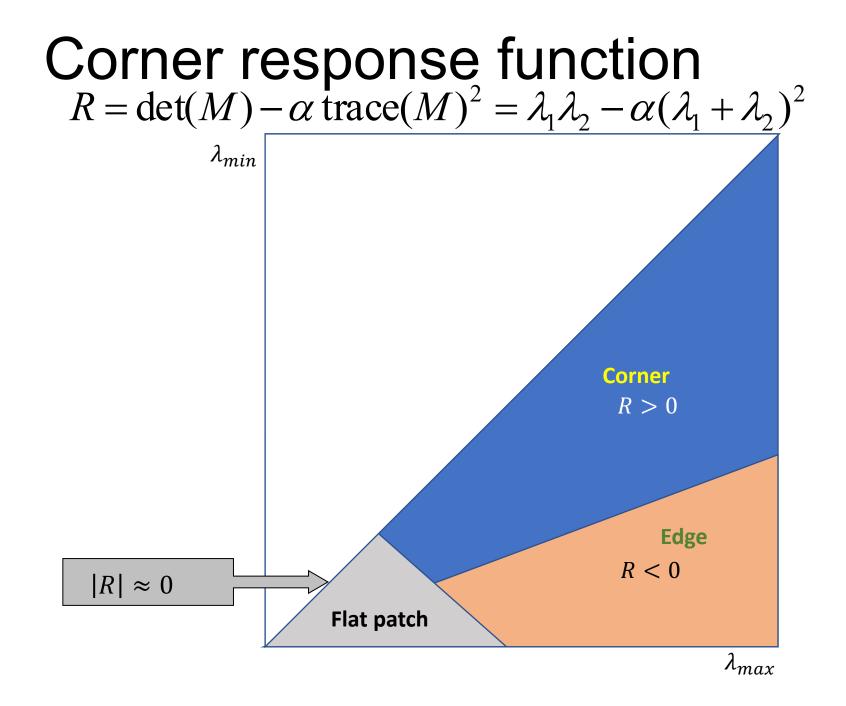


The Harris operator

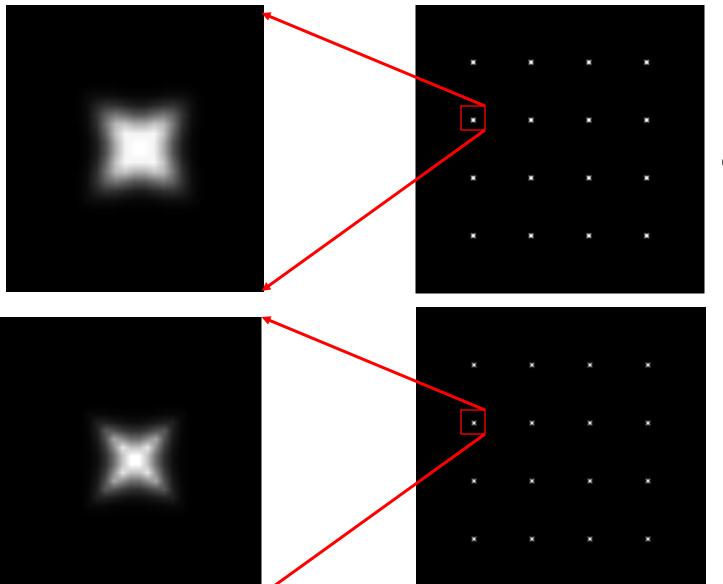
 λ_{min} is a variant of the "Harris operator" for feature detection

$$f = \frac{\lambda_1 \lambda_2}{\lambda_1 + \lambda_2}$$
$$= \frac{determinant(H)}{trace(H)}$$

- The *trace* is the sum of the diagonals, i.e., *trace(H)* = $h_{11} + h_{22}$
- Very similar to λ_{min} but less expensive (no square root)
- Called the "Harris Corner Detector" or "Harris Operator"
 - Actually the Noble variant of the Harris Corner Detector
- Lots of other detectors, this is one of the most popular



The Harris operator

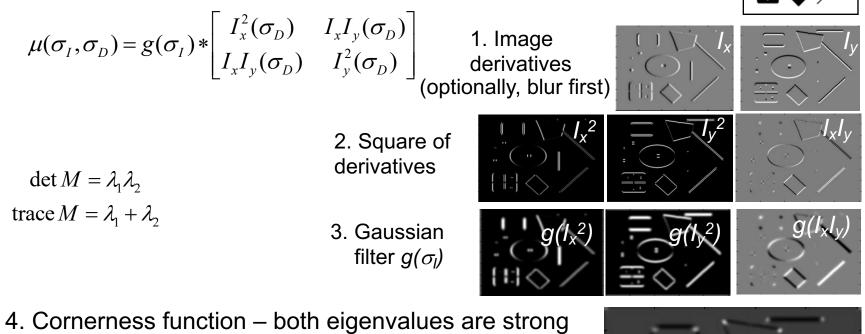


Harris operator

 λ_{\min}

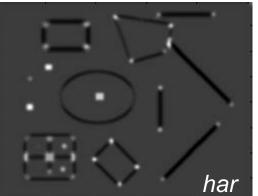
Harris Detector [Harris88]

Second moment matrix



$$har = \det[\mu(\sigma_{I}, \sigma_{D})] - \alpha[\operatorname{trace}(\mu(\sigma_{I}, \sigma_{D}))^{2}] = g(I_{x}^{2})g(I_{y}^{2}) - [g(I_{x}I_{y})]^{2} - \alpha[g(I_{x}^{2}) + g(I_{y}^{2})]^{2}$$

5. Non-maxima suppression



Weighting the derivatives

• In practice, using a simple window W doesn't work too well

$$H = \sum_{(x,y)\in W} \begin{bmatrix} I_x^2 & I_x I_y \\ I_x I_y & I_y^2 \end{bmatrix}$$

• Instead, we'll weight each derivative value based on its distance from the center pixel

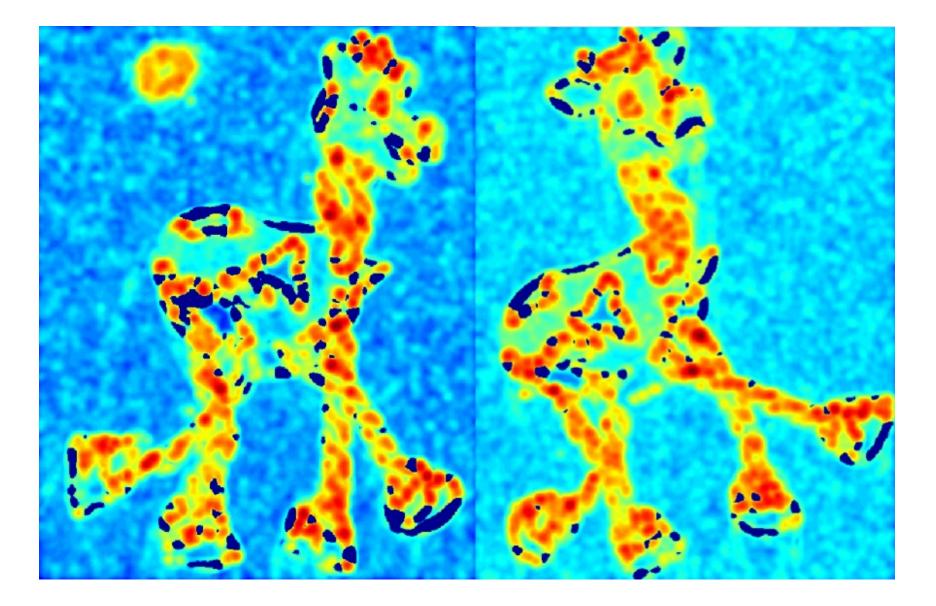
$$H = \sum_{(x,y)\in W} w_{x,y} \begin{bmatrix} I_x^2 & I_x I_y \\ I_x I_y & I_y^2 \end{bmatrix}$$



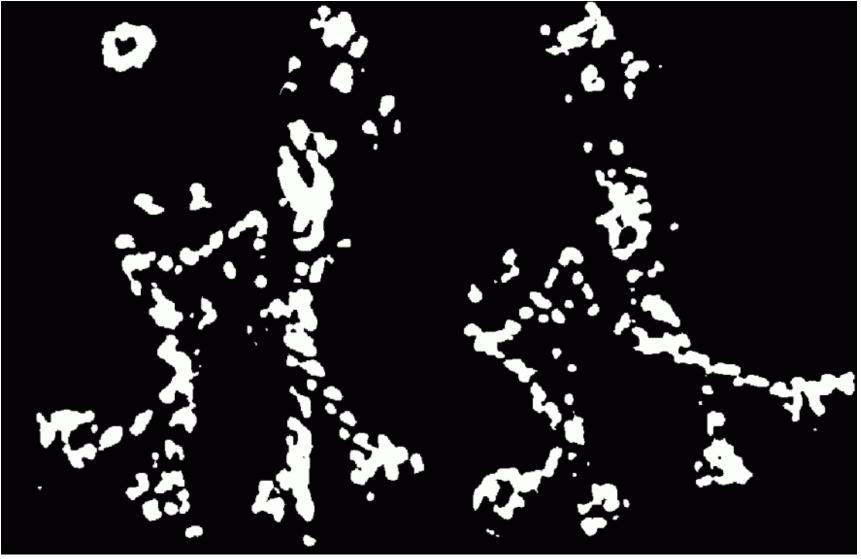
Harris detector example



f value (red high, blue low)



Threshold (f > value)



Find local maxima of f

• • •

Harris features (in red)

